

<b>Notice of References Cited</b>	Application/Control No. 10/685,064	Applicant(s)/Patent Under Reexamination PETER WEITZ	
	Examiner Khiem D Nguyen	Art Unit 2823	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,627,530	09-2003	Li et al.	438/622
*	B	US-2002/0075719	06-2002	Johnson et al.	365/130
*	C	US-2004/0130936	07-2004	Nguyen et al.	365/158
*	D	US-2004/0130935	07-2004	Gider et al.	365/158
*	E	US-5,640,343	06-1997	Gallagher et al.	365/171
*	F	US-2003/0202404	10-2003	Scheuerlein, Roy E.	365/200
*	G	US-6,624,011	09-2003	Subramanian et al.	438/152
*	H	US-2003/0077891	04-2003	Drynan, John M.	438/618
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.